


<b>Search Notes</b>  	<b>Application/Control No.</b>  10531569	<b>Applicant(s)/Patent Under Reexamination</b>  ZHANG ET AL.
	<b>Examiner</b>  REBECCA L PACHURA	<b>Art Unit</b>  4171

SEARCHED			
Class	Subclass	Date	Examiner
709	227, 230 with keyword search	12/04/2007	RLP
713	150-156, 168, 170 with keyword search	12/04/2007	RLP

SEARCH NOTES		
Search Notes	Date	Examiner
EAST-USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT	12/04-07/2007	RLP
Inventor's Search	12/07/2007	RLP
EAST-USPGPUB, USPAT, EPO, JPO, DERWENT, IBM_TDB	06/10/2008	RLP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner